

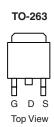
# **IRF9640S-VB Datasheet** P-Channel 200 V (D-S) MOSFET

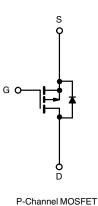
| PRODUCT SUMMARY          |                         |      |  |  |
|--------------------------|-------------------------|------|--|--|
| V <sub>DS</sub> (V)      | -200                    |      |  |  |
| R <sub>DS(on)</sub> (Ω)  | V <sub>GS</sub> = -10 V | 0.50 |  |  |
| Q <sub>g</sub> max. (nC) | 44                      |      |  |  |
| Q <sub>gs</sub> (nC)     | 7.1                     |      |  |  |
| Q <sub>gd</sub> (nC)     | 27                      |      |  |  |
| Configuration            | Single                  |      |  |  |

#### **FEATURES**

- Dynamic dV/dt rating
- Repetitive avalanche rated
- P-channel
- · Fast switching
- Ease of paralleling
- Simple drive requirements







| <b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted) |                          |   |                                   |             |          |  |
|--|--------------------------|---|-----------------------------------|-------------|----------|--|
| PARAMETER  |                          |   | SYMBOL                            | LIMIT       | UNIT     |  |
| Drain-Source Voltage   |                          |   | $V_{DS}$                          | -200        | V        |  |
| Gate-Source Voltage  |                          |   | $V_{GS}$                          | ± 20        | V        |  |
| Continuous Drain Current   | V <sub>GS</sub> at -10 V | $T_{\rm C} = 25  ^{\circ}{\rm C}$<br>$T_{\rm C} = 100  ^{\circ}{\rm C}$ |                                   | -11         |          |  |
|  |                          | T <sub>C</sub> = 100 °C   | I <sub>D</sub>                    | -6.8        | А        |  |
| Pulsed Drain Current <sup>a</sup>  |                          |   | I <sub>DM</sub>                   | -44         |          |  |
| Linear Derating Factor   |                          |   |                                   | 1.0         | W/°C     |  |
| Single Pulse Avalanche Energy b  |                          |   | E <sub>AS</sub>                   | 700         | mJ       |  |
| Repetitive Avalanche Current a   |                          |   | I <sub>AR</sub>                   | -11         | Α        |  |
| Repetitive Avalanche Energy <sup>a</sup>   |                          |   | E <sub>AR</sub>                   | 13          | mJ       |  |
| Maximum Power Dissipation  | T <sub>C</sub> = 25 °C   |   | $P_{D}$                           | 125         | W        |  |
| Peak Diode Recovery dV/dt <sup>c</sup>   |                          |   | dV/dt                             | -5.0        | V/ns     |  |
| Operating Junction and Storage Temperature Range                                 |                          |   | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | 00       |  |
| Soldering Recommendations (Peak temperature) <sup>d</sup>                        | for 10 s                 |   |                                   | 300         | °C       |  |
| Mounting Torque  | 6-32 or M3 screw         |   |                                   | 10          | lbf ⋅ in |  |
|  |                          |   |                                   | 1.1         | N⋅m      |  |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD}=$  -50 V, starting  $T_J=25$  °C, L=8.7 mH,  $R_g=25$   $\Omega$ ,  $I_{AS}=$  -11 A (see fig. 12). c.  $I_{SD}\leq$  -11 A, dI/dt  $\leq$  150 A/µs,  $V_{DD}\leq$   $V_{DS}$ ,  $V_{DS}$ 0 °C.

- d. 1.6 mm from case.



| THERMAL RESISTANCE RATINGS          |                   |      |      |      |  |
|-------------------------------------|-------------------|------|------|------|--|
| PARAMETER                           | SYMBOL            | TYP. | MAX. | UNIT |  |
| Maximum Junction-to-Ambient         | R <sub>thJA</sub> | =    | 62   |      |  |
| Case-to-Sink, Flat, Greased Surface | R <sub>thCS</sub> | 0.50 | -    | °C/W |  |
| Maximum Junction-to-Case (Drain)    | R <sub>thJC</sub> | -    | 1.0  |      |  |

| PARAMETER                                 | SYMBOL                | TES   | T CONDITIONS   | MIN.      | TYP.      | MAX.     | UNIT             |
|---|-----------------------|---|--|-----------|-----------|----------|------------------|
| Static                                    |                       |   |  |           | Į.        |          |                  |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>       | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$  |  | -200      | _         | -        | V                |
| V <sub>DS</sub> Temperature Coefficient   | $\Delta V_{DS}/T_{J}$ | Referenc  | e to 25 °C, I <sub>D</sub> = -1 mA   | -         | -0.2      | -        | V/°C             |
| Gate-Source Threshold Voltage             | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | V <sub>GS</sub> , I <sub>D</sub> = -250 μA                                       | -2.0      | -         | -4.0     | V                |
| Gate-Source Leakage                       | I <sub>GSS</sub>      | $V_{GS} = \pm 20 \text{ V}$   |  | -         | -         | ± 100    | nA               |
|   |                       | $V_{DS} = -200 \text{ V}, V_{GS} = 0 \text{ V}$   |  | -         | -         | -100     | μΑ               |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>      | V <sub>DS</sub> = -160 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                                |  | -         | -         | -500     |                  |
| Drain-Source On-State Resistance          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = -10 V   | I <sub>D</sub> = -6.6 A <sup>b</sup>   | -         | 0.50      | -        | Ω                |
| Forward Transconductance                  | 9 <sub>fs</sub>       | V <sub>DS</sub> = -50 V, I <sub>D</sub> = -6.6 A <sup>b</sup>   |  | 4.1       | -         | -        | S                |
| Dynamic                                   |                       | •   |  |           | •         | •        |                  |
| Input Capacitance                         | C <sub>iss</sub>      | $V_{GS} = 0 \text{ V}, \\ V_{DS} = -25 \text{ V}, \\ f = 1.0 \text{ MHz, see fig. 5}$                   |  | -         | 1200      | -        | pF               |
| Output Capacitance                        | Coss                  |   |  | -         | 370       | -        |                  |
| Reverse Transfer Capacitance              | C <sub>rss</sub>      |   |  | -         | 81        | -        |                  |
| Total Gate Charge                         | Qg                    | V <sub>GS</sub> = -10 V   | I <sub>D</sub> = -11 A, V <sub>DS</sub> = -160 V, see fig. 6 and 13 <sup>b</sup> | -         | -         | 44       | nC               |
| Gate-Source Charge                        | Q <sub>gs</sub>       |   |  | -         | -         | 7.1      |                  |
| Gate-Drain Charge                         | Q <sub>gd</sub>       |   |  | -         | -         | 27       |                  |
| Turn-On Delay Time                        | t <sub>d(on)</sub>    |   |  | -         | 14        | -        |                  |
| Rise Time                                 | t <sub>r</sub>        | V <sub>DD</sub> =   | V <sub>DD</sub> = -100 V, I <sub>D</sub> = -11 A                                 |           | 43        | -        | - ns             |
| Turn-Off Delay Time                       | t <sub>d(off)</sub>   | $R_g = 9.1 \Omega$ , $R_D = 8.6 \Omega$ , see fig. 10 b   |  | -         | 39        | -        |                  |
| Fall Time                                 | t <sub>f</sub>        |   |  | -         | 38        | -        |                  |
| Internal Drain Inductance                 | L <sub>D</sub>        | Between lead, 6 mm (0.25") from package and center of die contact                                       |  | -         | 4.5       | -        | - nH             |
| Internal Source Inductance                | L <sub>S</sub>        |   |  | -         | 7.5       | -        |                  |
| Gate Input Resistance                     | $R_g$                 | f = 1 MHz, open drain   |  | 0.3       | -         | 1.7      | Ω                |
| Drain-Source Body Diode Characteristic    | s                     |   |  |           |           |          |                  |
| Continuous Source-Drain Diode Current     | I <sub>S</sub>        | MOSFET symbol showing the integral reverse p -n junction diode  |  | -         | -         | -11      |                  |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>       |   |  | -         | -         | -44      | A                |
| Body Diode Voltage                        | V <sub>SD</sub>       | $T_J = 25  ^{\circ}\text{C},  I_S = -11  \text{A},  V_{GS} = 0  \text{V}  ^{\text{b}}$                  |  | -         | -         | -5       | V                |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>       | $T_J = 25  ^{\circ}\text{C}, I_F = -11  \text{A},  \text{dI/dt} = 100  \text{A/}\mu\text{s}^{\text{b}}$ |  | -         | 250       | 300      | ns               |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>       |   |  | -         | 2.9       | 3.6      | μC               |
| Forward Turn-On Time                      | t <sub>on</sub>       | Intrinsic tu  | rn-on time is negligible (turn   | on is dor | ninated b | v Le and | L <sub>D</sub> ) |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu s$ ; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

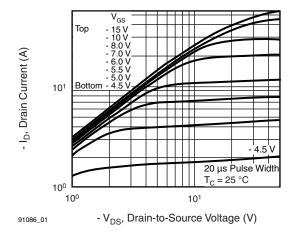


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

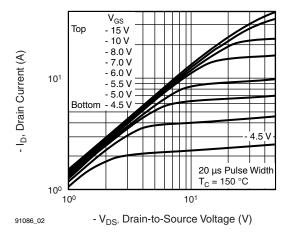


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

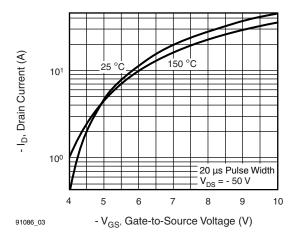


Fig. 3 - Typical Transfer Characteristics

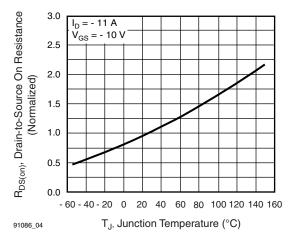


Fig. 4 - Normalized On-Resistance vs. Temperature

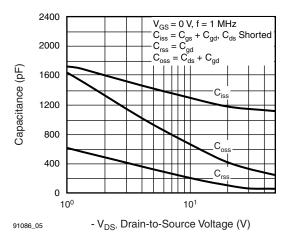


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

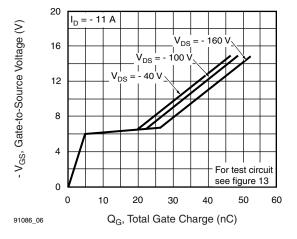


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage



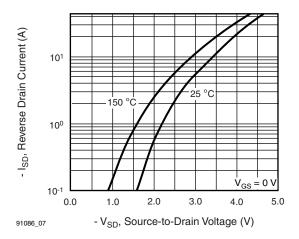


Fig. 7 - Typical Source-Drain Diode Forward Voltage

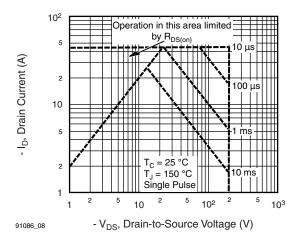


Fig. 8 - Maximum Safe Operating Area

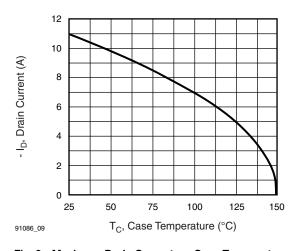


Fig. 9 - Maximum Drain Current vs. Case Temperature

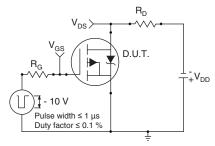


Fig. 10a - Switching Time Test Circuit

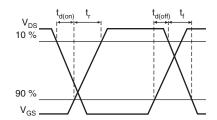


Fig. 10b - Switching Time Waveforms

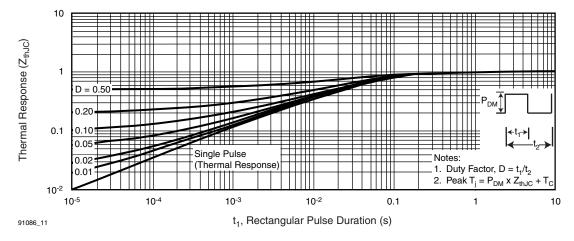


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



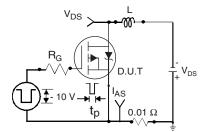


Fig. 12a - Unclamped Inductive Test Circuit

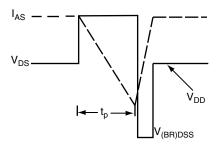


Fig. 12b - Unclamped Inductive Waveforms

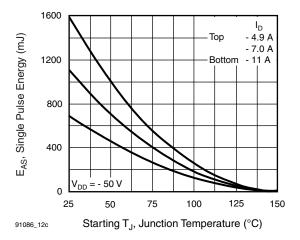


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

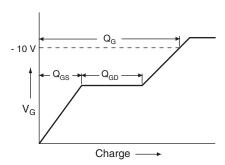


Fig. 13a - Basic Gate Charge Waveform

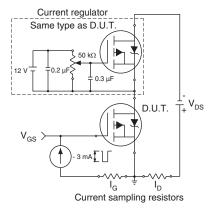
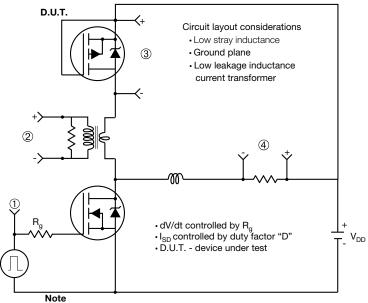


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

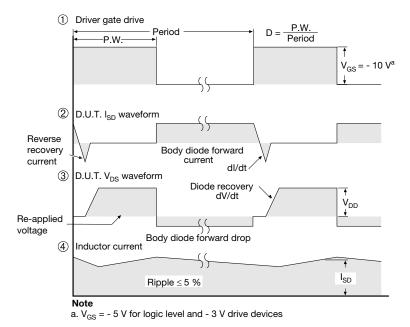
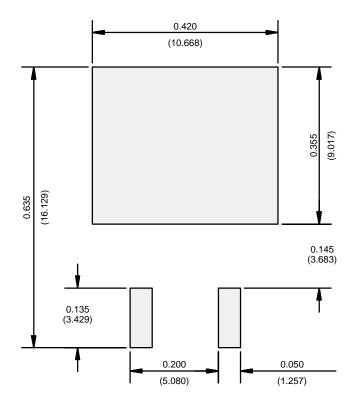


Fig. 14 - For P-Channel



### RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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